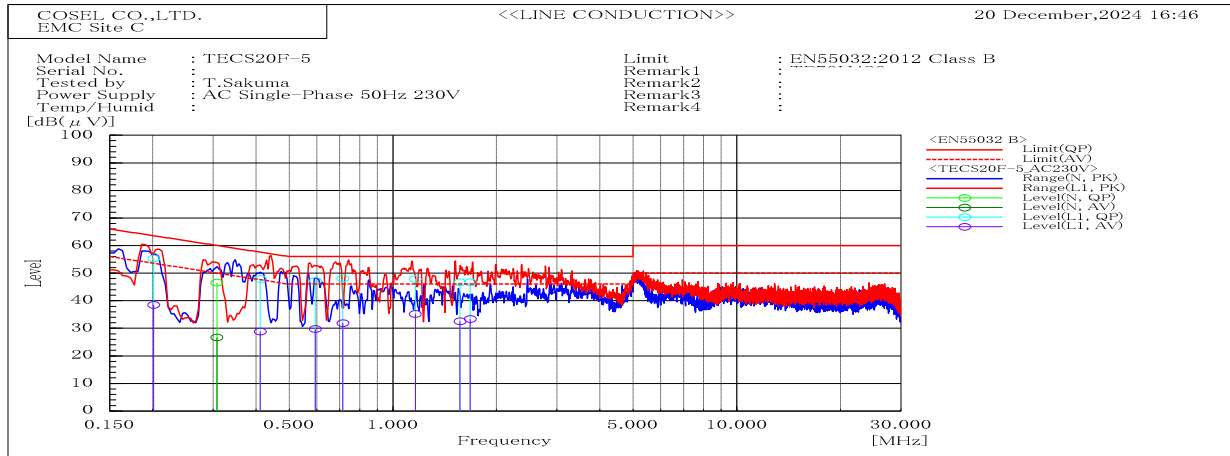
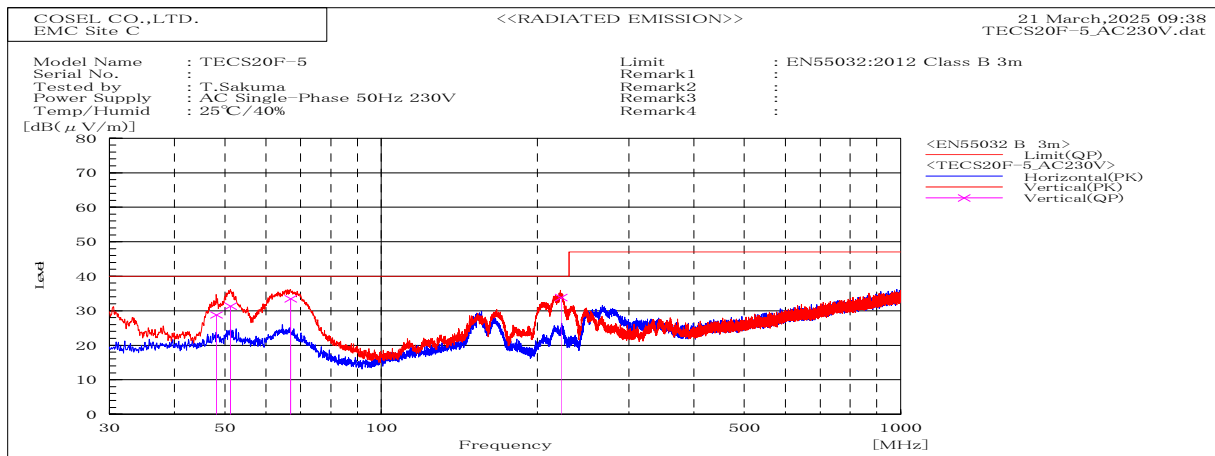


DATA SHEET

Model		TECS20F-5	Date	24-Mar-25
Test		EMI Line conduction & Radiated emission	Temp.	25 degreeC
			Humid.	40 %RH
			Tested by	T.Sakuma



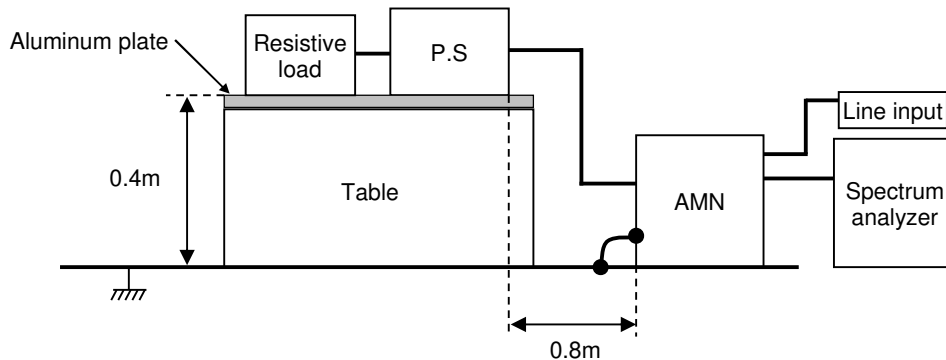
Frequency MHz	Line	Level dB(μV)		Limit dB(μV)		Margin dB		Pass/Fail	Remark
		QP	AV	QP	AV	QP	AV		
0.308	N	46.6	26.7	60	50	13.4	23.3	Pass	
0.411	L1	47.9	28.9	57.6	47.6	9.7	18.7	Pass	
0.594	L1	47.2	29.7	56	46	8.8	16.3	Pass	
0.715	L1	48.1	31.9	56	46	7.9	14.1	Pass	
1.161	L1	47.9	35.2	56	46	8.1	10.8	Pass	
1.568	L1	46.7	32.6	56	46	9.3	13.4	Pass	
1.678	L1	46.7	33.4	56	46	9.3	12.6	Pass	
0.201	L1	55.3	38.5	63.6	53.6	8.3	15.1	Pass	



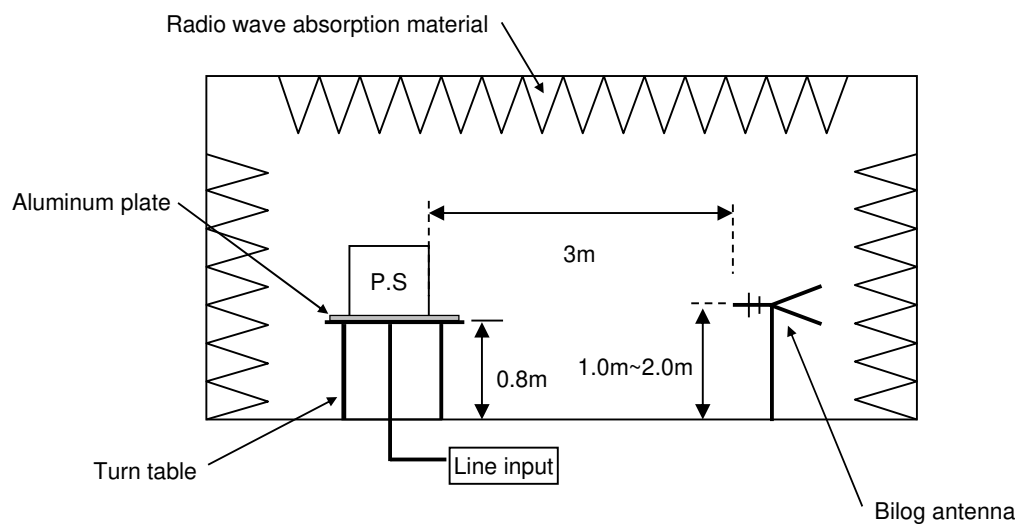
Frequency MHz	Polarization	Stability	Level dB(μV/m)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	QP					
48.148	V	Stable	28.8	40	11.2	Pass	100.2	7.6	
51.292	V	Stable	31.3	40	8.7	Pass	100.2	0	
66.975	V	Stable	33.5	40	6.5	Pass	100.2	136.8	
222.033	V	Stable	33.8	40	6.2	Pass	100.2	267.6	

DATA SHEET		Date	25-Mar-25
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Sakuma

1. Line conduction



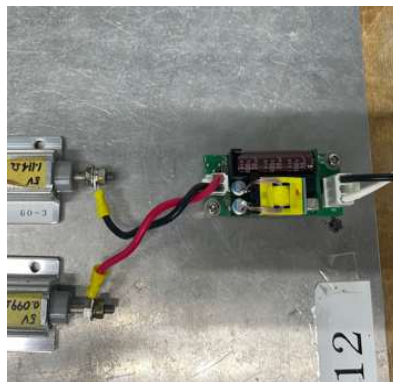
2. Radiated emission



Conditions

Test : EMI
Model Name : TECS20F-5

1.LINE CONDUCTION



2.RADIATED EMISSION

